•	Searcn	notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/748,277	KIM ET AL.	
Examiner	Art Unit	
Luz L. Alejandro	1763	

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED				
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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